Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/512,111	FENG, ZHIDE
Examiner	Art Unit
Christopher P. Schwartz	3683

Christopher P. Schwartz

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SEARCHED					
Class	Subclass	Date	Examiner		
74	480R	1/25/2007	CPS		
	562.5				
188	2D				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted w/ Fenstermacher class 74	1/25/2007			
EAST	·			
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